

# BCM61B

# NPN/NPN matched double transistor

Rev. 02 — 28 August 2009

**Product data sheet** 

### 1. Product profile

### 1.1 General description

NPN/NPN matched double transistor in a SOT143B small Surface-Mounted Device (SMD) plastic package. Matched version of BCV61.

PNP/PNP equivalent: BCM62B

#### 1.2 Features

Current gain matching

### 1.3 Applications

- Current mirror
- Differential amplifier

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per transis	stor TR1					
$V_{CEO}$	collector-emitter voltage	open base	-	-	45	V
h <sub>FE</sub>	DC current gain	$V_{CE} = 5 \text{ V};$ $I_C = 2 \text{ mA}$	200	290	450	
Per transis	stor					
I <sub>C</sub>	collector current		-	-	100	mA
Per device						
I <sub>C1</sub> /I <sub>E2</sub>	current matching	$V_{CE1} = 5 \text{ V};$ $I_{E2} = -0.5 \text{ mA};$ $T_{amb} \le 25 \text{ °C}$	<u>[1]</u> 0.92	1.02	1.12	

<sup>[1]</sup> Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.





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## 2. Pinning information

Table 2. Pinning

Table 2.	Pinning		
Pin	Description	Simplified outline	Symbol
1	collector TR2, base TR1 and TR2		
2	collector TR1	4 3	4 3
3	emitter TR1		TR2 TR1
4	emitter TR2	1 2	
			1 2
			006aaa842

### 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BCM61B	-	plastic surface-mounted package; 4 leads	SOT143B

## 4. Marking

Table 4. Marking codes

Type number	Marking code <sup>[1]</sup>
BCM61B	*AC

[1] \* = -: made in Hong Kong

\* = p: made in Hong Kong

\* = t: made in Malaysia

\* = W: made in China

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# 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per transis	stor TR1				
$V_{CBO}$	collector-base voltage	open emitter	-	50	V
$V_{CEO}$	collector-emitter voltage	open base	-	45	V
Per transis	stor				
$V_{EBS}$	emitter-base voltage	$V_{CB} = 0 V$	-	6	V
I <sub>C</sub>	collector current		-	100	mA
I <sub>CM</sub>	peak collector current	single pulse; t <sub>p</sub> ≤ 1 ms	-	200	mA
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25  ^{\circ}C$	<u>[1]</u> -	220	mW
Per device					
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25  ^{\circ}C$	<u>[1]</u> -	390	mW
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

### 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per trans	istor					
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	<u>[1]</u> -	-	568	K/W
Per device						
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	in free air	[1] -	-	321	K/W

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

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## 7. Characteristics

Table 7. Characteristics

 $T_{amb} = 25 \,^{\circ}C$  unless otherwise specified

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per transis	tor TR1						
I <sub>CBO</sub>	collector-base cut-off current	$V_{CB} = 30 \text{ V};$ $I_{E} = 0 \text{ A}$		-	-	15	nA
		$V_{CB} = 30 \text{ V};$ $I_{E} = 0 \text{ A};$ $T_{j} = 150 \text{ °C}$		-	-	5	μΑ
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$		-	-	100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = 5 \text{ V};$ $I_C = 10 \mu\text{A}$		-	250	-	
		$V_{CE} = 5 \text{ V};$ $I_{C} = 100 \mu\text{A}$		100	-	-	
		$V_{CE} = 5 \text{ V};$ $I_C = 2 \text{ mA}$		200	290	450	
V <sub>CEsat</sub>	collector-emitter saturation voltage	$I_C = 10 \text{ mA};$ $I_B = 0.5 \text{ mA}$		-	50	200	mV
		$I_{C} = 100 \text{ mA};$ $I_{B} = 5 \text{ mA}$		-	200	400	mV
V <sub>BEsat</sub>	base-emitter saturation voltage	$I_C = 10 \text{ mA};$ $I_B = 0.5 \text{ mA}$	<u>[1]</u>	-	760	-	mV
		$I_{C} = 100 \text{ mA};$ $I_{B} = 5 \text{ mA}$	[1]	-	910	-	mV
$V_{BE}$	base-emitter voltage	$V_{CE} = 5 \text{ V};$ $I_{C} = 2 \text{ mA}$	[2]	610	660	710	mV
		$V_{CE} = 5 \text{ V};$ $I_{C} = 10 \text{ mA}$	[2]	-	-	770	mV
C <sub>c</sub>	collector capacitance	$V_{CB} = 10 \text{ V};$ $I_E = i_e = 0 \text{ A};$ f = 1  MHz		-	-	1.5	pF
C <sub>e</sub>	emitter capacitance	$V_{EB} = 0.5 \text{ V};$ $I_C = i_c = 0 \text{ A};$ $f = 1 \text{ MHz}$		-	11	-	pF
f <sub>T</sub>	transition frequency	$V_{CE} = 5 \text{ V};$ $I_{C} = 10 \text{ mA};$ $f = 100 \text{ MHz}$		100	250	-	MHz
NF n	noise figure	$V_{CE} = 5 \text{ V};$ $I_{C} = 0.2 \text{ mA};$ $R_{S} = 2 \text{ k}\Omega;$ $f = 10 \text{ Hz to}$ $15.7 \text{ kHz}$		-	2.8	-	dB
		$\begin{split} &V_{CE}=5 \text{ V;} \\ &I_{C}=0.2 \text{ mA;} \\ &R_{S}=2 \text{ k}\Omega; \\ &f=1 \text{ kHz;} \\ &B=200 \text{ Hz} \end{split}$		-	3.3	-	dB

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**Table 7.** Characteristics ...continued  $T_{amb} = 25 \,^{\circ}C$  unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per transis	stor TR2					
V <sub>EBS</sub>	emitter-base voltage	$V_{CB} = 0 \text{ V};$ $I_E = -250 \text{ mA}$	-	-	-1.8	V
		$V_{CB} = 0 \text{ V};$ $I_E = -10 \mu\text{A}$	-400	-	-	mV
Per device	•					
I <sub>C1</sub> /I <sub>E2</sub> current m	current matching	$V_{CE1} = 5 \text{ V};$ $I_{E2} = -0.5 \text{ mA};$ $T_{amb} \le 25 \text{ °C}$	[ <u>3</u> ] 0.92	1.02	1.12	
		$V_{CE1} = 5 \text{ V};$ $I_{E2} = -0.5 \text{ mA};$ $T_{amb} \le 150 \text{ °C}$	[ <u>3]</u> 0.93	-	1.13	
		$V_{CE1} = 3 \text{ V};$ $I_{E2} = -0.5 \text{ mA};$ $T_{amb} \le 25 \text{ °C}$	[ <u>3</u> ] 0.91	1.01	1.11	
		$V_{CE1} = 1 \text{ V};$ $I_{E2} = -0.5 \text{ mA};$ $T_{amb} \le 25 \text{ °C}$	[ <u>3]</u> 0.9	1	1.1	

<sup>[1]</sup>  $V_{BEsat}$  decreases by about 1.7 mV/K with increasing temperature.

<sup>[2]</sup> V<sub>BE</sub> decreases by about 2 mV/K with increasing temperature.

<sup>[3]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

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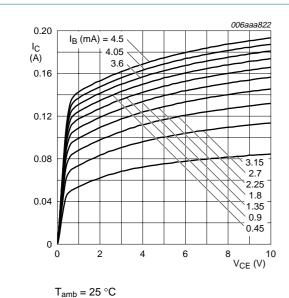
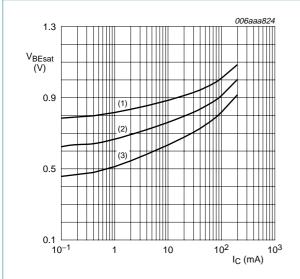


Fig 1. Collector current as a function of collector-emitter voltage; typical values



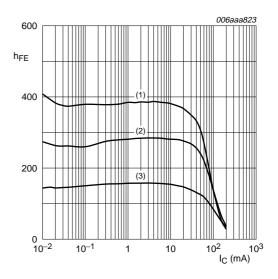
 $I_{\rm C}/I_{\rm B}=20$ 

(1)  $T_{amb} = -55 \,^{\circ}C$ 

(2)  $T_{amb} = 25 \, ^{\circ}C$ 

(3)  $T_{amb} = 100 \, ^{\circ}C$ 

Fig 3. Base-emitter saturation voltage as a function of collector current; typical values



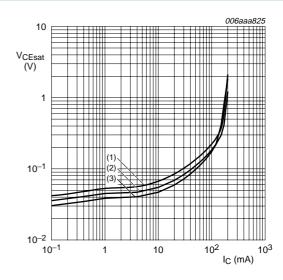
 $V_{CE} = 5 V$ 

(1)  $T_{amb} = 100 \, ^{\circ}C$ 

(2)  $T_{amb} = 25 \, ^{\circ}C$ 

(3)  $T_{amb} = -55 \, ^{\circ}C$ 

Fig 2. DC current gain as a function of collector current; typical values



 $I_{\rm C}/I_{\rm B}=20$ 

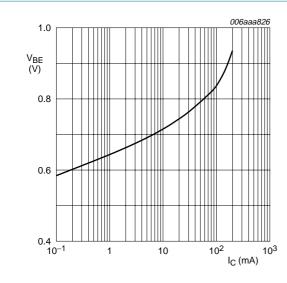
(1)  $T_{amb} = 100 \, ^{\circ}C$ 

(2)  $T_{amb} = 25 \, ^{\circ}C$ 

(3)  $T_{amb} = -55 \, ^{\circ}C$ 

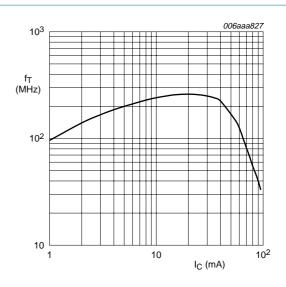
Fig 4. Collector-emitter saturation voltage as a function of collector current; typical values

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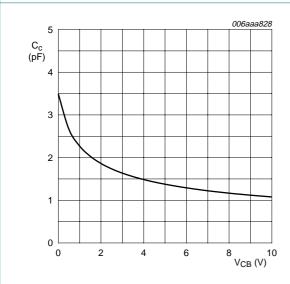
 $V_{CE} = 5 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}$ 

Fig 5. Base-emitter voltage as a function of collector current; typical values



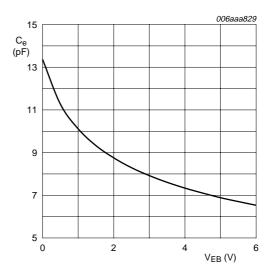
 $V_{CE} = 5 \text{ V}; T_{amb} = 25 \,^{\circ}\text{C}$ 

Fig 6. Transition frequency as a function of collector current; typical values



 $f = 1 \text{ MHz}; T_{amb} = 25 \,^{\circ}\text{C}$ 

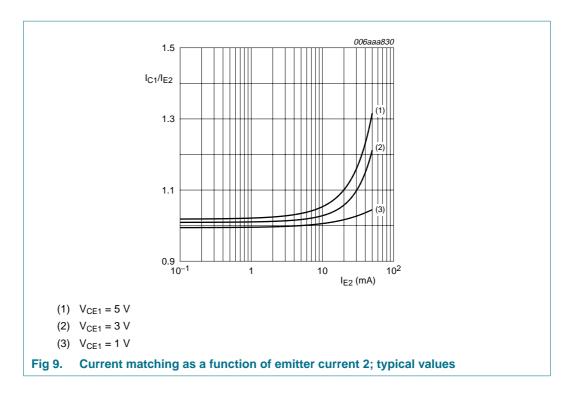
Fig 7. Collector capacitance as a function of collector-base voltage; typical values



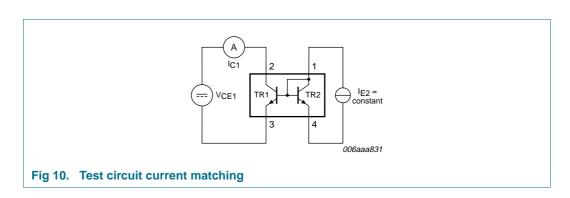
 $f = 1 \text{ MHz}; T_{amb} = 25 ^{\circ}\text{C}$ 

Fig 8. Emitter capacitance as a function of emitter-base voltage; typical values

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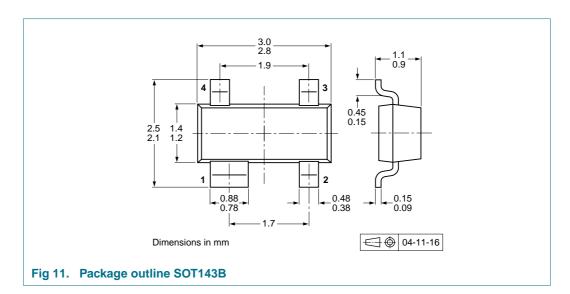


### 8. Test information



#### **NPN/NPN** matched double transistor

## 9. Package outline



# 10. Packing information

Table 8. Packing methods

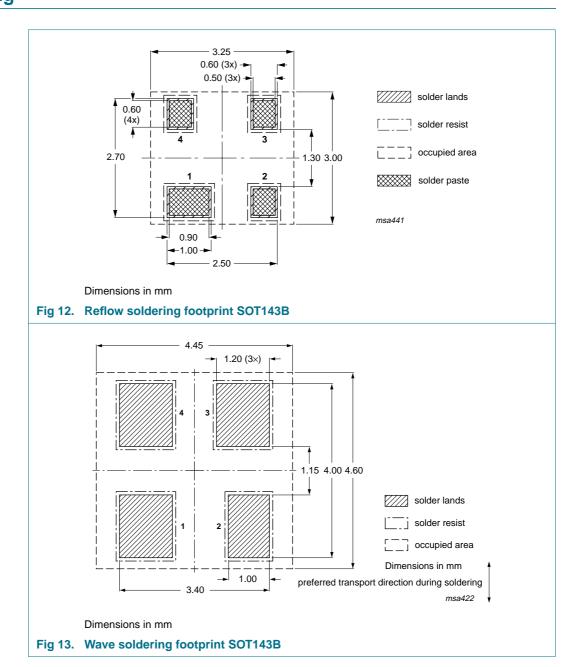
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description	Packing qua	intity
			3000	10000
BCM61B	SOT143B	4 mm pitch, 8 mm tape and reel	-215	-235

<sup>[1]</sup> For further information and the availability of packing methods, see Section 14.

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## 11. Soldering



#### **NPN/NPN** matched double transistor

# 12. Revision history

#### Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BCM61B_2	20090828	Product data sheet	-	BCM61B_1
Modifications:	<ul> <li>This data sheet was changed to reflect the new company name NXP Semiconductors including new legal definitions and disclaimers. No changes were made to the technic content.</li> </ul>			
	• Figure 13 "\	Nave soldering footprint So	OT143B": updated	
BCM61B_1	20060919	Product data sheet	-	-

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### 13. Legal information

#### 13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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- [2] The term 'short data sheet' is explained in section "Definitions"
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